

6456401

TEST REPORT

Power Density Test for certification of SM-F741U

APPLICANT

Samsung Electronics. Co., Ltd.

REPORT NO.

HCT-SR-2404-FC005

DATE OF ISSUE

Apr. 26, 2024

Tested byByeong Chul, Yoon

Technical Manager Yun Jeang, Heo (signature)

HCT CO., LTD. Bongsai Huh / CEO

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TEST REPORT

FCC Part 1 PD Test for certification

REPORT NO.

HCT-SR-2404-FC005

DATE OF ISSUE

Apr. 26, 2024

FCC ID

A3LSMF741U

Applicant	SAMSUNG Electronics Co., Ltd 129, Samsung-ro, Yeongtong-gu, Suwon-Si, Gyeonggi-do, 16677, Korea
Product Name Model Name Additional Model Name	Mobile Phone SM-F741U SM-F741U1
Date of Test	Apr. 12, 2024 ~ Apr. 23, 2024
Location of Test	■ Permanent Testing Lab □ On Site Testing Lab (Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si,
FCC Rule Part(s)	CFR §2.1093
Test Results	PASS (Power Density Limit: 1.0 mW/cm²)

Band & Mode	Frequency Range	Measured psPD	Reported psPD	
Balla & Wode	[MHz]	mW /cm ²	mW /cm ²	
n258	24250 - 24450, 24750 ~ 25 250	0.511	0.977	
n261	27500 - 28350	0.575	0.977	
n260	37000 - 40000	0.692	0.977	
Total exposure Ratio	0	.979		

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REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	Apr. 26, 2024	Initial Release

Notice

Content

The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated.

The test results have only been applied with the test methods required by the standard(s).

The laboratory is not accredited for the test results marked *.

Information provided by the applicant is marked **.

Test results provided by external providers are marked ***.

When confirmation of authenticity of this test report is required, please contact www.hct.co.kr

The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

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1. Test Location

1.1 Test Laboratory

Company Name	HCT Co., Ltd.
Address	74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi- do, 17383 KOREA
Telephone	031-645-6300
Fax.	031-645-6401

1.2 Test Facilities

Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

Varia	National Radio Research Agency (Designation No. KR0032)
Korea	KOLAS (Testing No. KT197)

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2. Information of the EUT

Model Name	SM-F741U
Additional Model Name	SM-F741U1
Equipment Type	Mobile Phone
FCC ID	A3LSMF741U
Application Type	Certification
Applicant	SAMSUNG Electronics Co., Ltd.

2.1 NR FR2 Device Description.

Item.				Description						
NR Band r				24 250 MHz ~ 24 450 MHz; 24 750 MHz ~ 25 250 MHz						
Frequency Range		NR Band n260		37 000 MHz - 40 000 MHz						
, , ,		NR Band n261		27 000 MHz — 28 500 MHz						
		NR Band			Hz, 100 MHz					
Channel Bandwidths		NR Band			Hz, 100 MHz					
		NR Band		50 MHz, 100 MHz						
		Low				channel		Channel		
Ch. No.& Freq		Channel	_	uenc /	Channe	Frequenc v	Channe I	Frequenc v		
	100 MHz	2071667	P		2077915	27924.96	2084165	28299.96		
NR Band n261	50 MHz	2071249		525	2077915	27924.96	2084581	28324.92		
	100 MHz	2229999)50	2254165	38499.96	2278331	39949.92		
NR Band n260	50 MHz	2229853		25.04	2254165	38499.96	2278749	39975		
NID D. J. OFO	100 MHz	2018333			2025833	24800.04	2032499			
NR Band n258	50 MHz	2018333	2435	0.04	2025417	24775.08	2032915	25224.96		
Subcarrier Spacing (kHz)			120							
Total Number of Suppo	rted Uplink (CCs (SISO)	4 (DFT-s-OFDM, CP-OFDM)							
Total Number of Suppo	rted Uplink (CCs (MIMO	4 (DFT-s-OFDM, CP-OFDM)							
Modulations Supported in UL			DFT-S-OFDM: Pi/2 BPSK, QPSK,16QAM, 64QAM CP-OFDM: QPSK, 16QAM, 64QAM							
LTE Anchor Bands (n260))		LTE E	Band 2	2/5/12/13/	14/30/48/66				
LTE Anchor Bands (n26°	1)		LTE E	Band 2	2/4/5/12/1	3/48/66				
LTE Anchor Bands (n258	3)		LTE E	Band 2	2/5/12/66/	71				
NR FR1 Anchor Bands (n258)		NR Band n2/12/25/41/66/77							
NR FR1 Anchor Bands (n260)			NR Band n2/5/12/25/30/41/48/66/77							
NR FR1 Anchor Bands (n261)			NR Band n2/5/25/41/48/66/77							
Duplex Type (mmWave)			TDD							
		XCJ1368M								
Device Serial Numbers		testec charac	l have cteristi	the same	s confirmed physical, me nin operatior on units.	chanical a	and thermal			

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2.2 Time-Averaging Algorithm for RF Exposure Compliance

The device is enabled with Qualcomm® Smart Transmit (GEN2) feature. This feature performs time averaging algorithm in real time to control and manage transmitting power and ensure the time-averaged RF exposure is in compliance with FCC requirements all the time.

The Smart Transmit algorithm maintains the time-averaged transmit power, in turn, time-averaged RF exposure of SAR_design_target or PD_design_target, below the predefined time-averaged power limit (i.e., Plimit for sub-6 radio, and input.power.limit for 5G mmW NR), for each characterized technology and band (see Part 0 PD Report).

Smart Transmit allows the device to transmit at higher power instantaneously when needed, but manages power limiting to maintain time-averaged transmit power to input.power.limit. The purpose of this report (Part 1 test) is to demonstrate that the EUT meets FCC PD limits when transmitting in static transmission scenario at maximum allowable time-averaged power level given by input.power.limit

Power density Design Target and Uncertainty		
PD_design_target (mW/m²) 0.631		
Design Related Total Uncertainty (dB)	2	

2.3 Test Regulations

November 2017, October 2018, April 2019, November 2019 TCBC Workshop Notes SPEAG DASY6 System Handbook (September 2019)

IEC TR 63170:2018

FCC KDB 865664 D02 v01r02

FCC KDB 447498 D01 v06

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2.4 DUT Antenna Locations

The device has one patch antenna arrays (K Patch). Tablebelow indicates the surfaces evaluated for part 1 near field power density evaluation.

5G mmWave NR Device Surfaces

Band	Antenna	Condition	Rear (S2)	Front (S1)	Left (S3)	Right (S4)	Bottom (S6)	Top (S5)
NR n261	Patch K	Open	No	Yes	Yes	No	No	No
NR n260	Patch K	Open	Yes	No	Yes	No	No	No
NR n258	Patch K	Open	Yes	Yes	Yes	No	No	No
NR n261	Patch K	Closed	No	No	Yes	No	No	No
NR n260	Patch K	Closed	No	No	Yes	No	No	No
NR n258	Patch K	Closed	No	Yes	Yes	No	No	No

Note:

- 1. All test configurations are based on front position view.
- 2. Additional surfaces were evaluated for simultaneous transmission analysis.

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2.5 Simultaneous Transmission Capabilities

According to FCC KDB Publication 447498 D01v06, transmitters are considered to be operating simultaneously when there is overlapping transmission, with the exception of transmissions during network hand-offs with maximum hand-off duration less than 30 seconds.

The device contains multiple transmitters that may operate simultaneously, and therefore requires a simultaneous transmission analysis according to FCC KDB Publication 447498 D01v06 4.3.2 procedures.

5G mmWave NR Simultaneous Transmission Scenarios						
Applicable Combination	Head	Body worn	Wireless Router	Phablet		
LTE + 5G NR FR2	Yes	Yes	N/A	Yes		
LTE + 2.4 GHz WI-FI + 5G FR2	Yes	Yes	Yes	Yes		
LTE + 5 GHz WI-FI + 5G NR FR2	Yes	Yes	Yes	Yes		
LTE + 6 GHz WI-FI + 5G NR FR2	Yes	Yes	N/A	Yes		
LTE + 2.4 GHz Bluetooth + 5G NR FR2	Yes^	Yes	Yes^	Yes		
LTE + 2.4 GHz Bluetooth +2.4 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
LTE + 2.4 GHz Bluetooth + 5 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
LTE + 2.4 GHz Bluetooth + 6 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
LTE + 2.4 GHz WI-FI + 5 GHz WI-FI + 5G NR FR2	Yes	Yes	Yes	Yes		
LTE + 2.4 GHz WI-FI + 6 GHz WI-FI + 5G NR FR2	Yes	Yes	Yes	Yes		
LTE + 2.4 GHz Bluetooth + 5 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
LTE + 2.4 GHz Bluetooth + 6 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
5G NR FR1 + 5G NR FR2	Yes	Yes	N/A	Yes		
5G NR FR1 + 2.4 GHz WI-FI + 5G FR2	Yes	Yes	Yes	Yes		
5G NR FR1 + 5 GHz WI-FI + 5G NR FR2	Yes	Yes	Yes	Yes		
5G NR FR1 + 6 GHz WI-FI + 5G NR FR2	Yes	Yes	N/A	Yes		
5G NR FR1 + 2.4 GHz Bluetooth + 5G NR FR2	Yes^	Yes	Yes^	Yes		
5G NR FR1 + 2.4 GHz Bluetooth +2.4 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
5G NR FR1 + 2.4 GHz Bluetooth + 5 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
5G NR FR1 + 2.4 GHz Bluetooth + 6 GHz WI-FI + 5G NR FR2	Yes^	Yes	Yes^	Yes		
5G NR FR1 + 2.4 GHz WI-FI + 5 GHz WI-FI + 5G NR FR2	Yes	Yes	Yes	Yes		
5G NR FR1 + 2.4 GHz WI-FI + 6 GHz WI-FI + 5G NR FR2	Yes	Yes	Yes	Yes		

Note:

- 1. 5G NR Operations are limited to Non-Standalone (EN-DC) operations only.
- 2. LTE + 5G NR FR2 and 5G NR FR1 + 5G NR FR2 Scenarios are limited to EN-DC combinations with anchor bands as shown in the NR FR2 checklists
- 3. This device supports time averaging smart transmit algorithm in WWAN and WLAN. Smart transmit adds directly the time-averaged RF exposure from 4G/5G NR FR1/WLAN and time-averaged RF exposure from 5G mmW NR FR2 to ensure that the normalized RF exposure from both 4G/5G NR FR1/WLAN and 5G mmW NR FR2 does not exceed FCC limit.
- 4. NFC can transmit simultaneously with all scenarios above.
- 5. ^ Bluetooth Tethering is considered

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3. Description of test equipment

3.1 MEASUREMENT SETUP

Peak spatially averaged power density(psPD) measurements for mmWave frequencies were performed using the DASY6 with cDASY6 5G module.

The DASY6 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of a high precision robotics system (Staubli), robot controller, desktop computer, near-field probe, probe alignment sensor, and the 5G phantom. The robot is a six-axis industrial robot, performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).

3.2 SPEAG EUmmWV3 Probe / E-Field 5G Probe

The EUmmWV4 probe consists of two dipoles optimally arranged to obtain pseudo-vector information.

Frequency Range	750 MHz – 110 GHz
Dynamic Range	< 20 V/m - 10,000 V/m with PRE-10 (min < 50 V/m - 3,000 V/m)
Position Precision	< 0.2 mm (cDASY6)
Dimensions	Probe Overall Length: 320 mm Probe Body Diameter: 8 mm Probe Tip Length: 23 mm Probe Tip Diameter: Encapsulation 8 mm Distance from Probe Tip to Sensor X Calibration Point: 1.5 mm Distance from Probe Tip to Sensor Y Calibration Point: 1.5 mm
Applications	E-field measurements of 5G devices and other mm-wave transmitters operating above 10 GHz in < 2 mm distance from device (free-space) Power density, H-field and far-field analysis using total field reconstruction
Compatibility	cDASY6 + 5G-Module SW

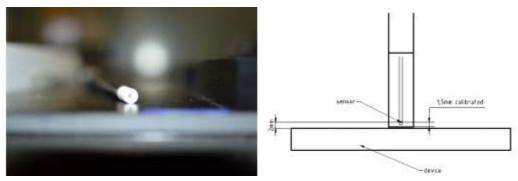


Figure 1. EUmmWV4 Probe

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3.3 Peak Spatially Averaged Power Density Assessment Based on E-field Measurements

Within a short distance from the transmitting source, Power density was determined based on both electric and magnetic field. Generally, the magnitude and phase of two components of either the E-field or H-field were needed on a sufficiently large surface to fully characterized the total E-field and H-field can be used to compute power density. The general measurement approach used for this device was:

- a) The local E-field on the measurement surface was measured at a reference location where the field is well above the noise level. This reference level was used at the end of this procedure to assess output power drift of the DUT during the measurement.
- b) The electric field on the measurement surface was scanned. Measurements are conducted according to the instructions provided by the measurement system manufacturer. Measurement spatial resolution can depend on the measured field characteristic and measurement methodology used by the system. The planar scan step size was configured at $\lambda/4$.
- c) For cDasy6, H-field was calculated from the measured E-field using a reconstruction algorithm. As the power density calculation requires knowledge of both amplitude and phase, reconstruction algorithms can also be used to obtain field information from the measured E-field data (e.g. the phase from the amplitude if only the amplitude is measured). H-field and phase data was reconstructed from repeated measurements (three per measurement point) on two measurement planes separated by $\lambda/4$.
- d) The total Peak spatially averaged power density (psPD) distribution on the evaluation surface is determined per the below equation. The spatial averaging area, A, is specified by the applicable exposure limits or regulatory requirements. A circular shape was used.

$$psPD = \frac{1}{2A_{av}} \iint_{A_{av}} ||Re\{E \times H^*\}|| dA$$

- e) The maximum spatial-average on the evaluation surface is the final quantity to determine compliance against applicable limits.
- f) The local E-filed reference value, at the same location as step 2, was re-measured after the scan was complete to calculate the power drift. If the drift deviated by more than 5%, the power density test and drift measurements were repeated.

3.4 Reconstruction Algorithm

Computation of the power density in general requires menasrement information from the both E-field and H-field amplitudes and phases in the plane of incidence. Reconstruction of these quantities from pseudo-vector E-field measurements is feasible according to the manufacturer, as they are determined via Maxwells's equation. As such, the SPEAG reconstruction approach was based on the Gerchbergns. As such, the SPEAG reconstruction approach was based on the Gerchberg-Saxton algorithm, which benefits from the availability of the E-field polarzation ellipse information obtained with the EUmmWV4 probe.

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4. RF Exposure Limits

Per $\S1.1310$ (d)(3), the MPE limits are applied for frequencies above 6 GHz. Power Density is expressed in units of W/m² or mW/cm².

Peak Spatially Averaged Power Density was evaluated over a circular area of 4 m² per interim FCC Guidance for near-field power density evaluations per October 2018 TCB Workshop notes.

HUMAN EXPOSURE	Limits For Occupational / Controlled Environments	Limits For General Population / Uncontrolled Environments
Frequency Range[MHz]	1,500 – 100,000	1,500 – 100,000
Power Density[mW/cm²]	5.0	1.0
Average Time[Minutes]	6	30

NOTES: 1.0 mW/cm² is 10 W/m²

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure. The general population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be mad fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment-related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e.as a result of employment or occupation). In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

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5. Input Power Specifications

All power density measurements for this device were performed at the input.power.limit given in below tables.

Table 5-1 5G NR n258 K Patch input.power.limit

Antenna	Beam ID_1	Beam ID_2	Input.power.limit(dBm)
7 tireerina	0	Beam 15_2	12.5
	1		9.4
	2		9.6
	3		9.4
	4		10.1
	5 6		5.8 6.7
	7		5.9
	8		6.7
	9		9.9
	10		8.8
	11 12	+	6.5 2.7
	13		2.7
	14		2.3
	15		2.2
	16		2.0
	17 18		2.7 2.7
	19		2.2
	20		1.8
	256		13.0
	257		11.4
	258 259		12.6 12.2
	260		12.5
	261		8.2
	262		9.8
	263		8.7
	264 265		9.5 10.9
K Patch	266		9.3
it rateri	267		8.6
	268		9.6
	269		6.4
	270 271		6.0 5.8
	272		4.3
	273		7.3
	274		6.4
	275		5.6
	276	256	4.1
	0	256 257	8.6 7.0
	2	258	7.1
	3	259	6.9
	4	260	7.2
	5	261	3.2
	<u>6</u> 7	262 263	4.1 3.8
	8	264	4.1
	9	264 265	6.6
	10	266	5.9
	11	267	4.7 1.3
	12 13	268 269	1.3 0.4
	14	270	0.4 -0.1
	15	271	-0.1
	16	272	-0.9 0.5
	17	273	0.5
	18 19	274 275	0.4 -0.3
	20	276	-0.5
1			1.0

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Table 5-3 5G NR n261 K Patch input.power.limit

	DIE 3-3 30 INK IIZOT	1	
Antenna	Beam ID_1	Beam ID_2	Input.power.limit(dBm)
	0		8.4
	1		9.6
	2		9.1
	3		8.7
	4		9.3
	5		6.4
	6		5.5
	7		5.6
	8		6.4
	9		5.8
	10		5.6
	11		6
	12		2.2
	13		2
	14		1.9
	15		1.4
	16		2.2
	17		2
	18		2.2
	19		1.7
	20		1.8
	256		12
	257		10.5
	258		10.5
	258 259		10.4
	260		10.6
	261		8.4
	262		7.3
	263		7.1
	264		7.9
	265		7.2
K Patch	266		6.9
	267		7.5
	268		4.2
	269		3.6
	270		3.7
	271		3.9
	272		3.1
	273		3.8
	274		3.8 3.7
	275		3.6
	276		3.3
	0	256	5.6
	1	257	6.1
	2	258	5.5
	3	259	5.6
	4	260	6.1
	5	261	3.6
	6	262	2.7
	7	263	2.9
	· · · · · · · · · · · · · · · · · · ·	264	
	8 9	265	3.5 3.1
	10	266	3
	11	267	3.7
	12	268	-0.9
	13	269	-1.1
	14	270	-1.1
	15	271	-1.3
	16	272	-1.3
	17	273	-1.1
	18	274	-0.9
	19	275	-1.2
	20	276	-1.2

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Table 5-3 5G NR n260 K Patch input.power.limit

Antenna	Beam ID_1	Beam ID_2	Input.power.limit(dBm)
	0	_	9.7
	1		9.6
	2		8.9
	3		9.5
	4		9.7
	5		6.6
	6		6.9
	7		6.2
	8 9		6.2 7.3
	10		6.7
	11		6.2
	12		3.5
	13		4
	14		3.2
	15		2.6
	16		2.5
	17		3.3
	18		4.2
	19		2.9
	20		2.4
	256		10.6
	257		9.6
	258 259		8.7
	259		8.9
	260		9.3
	261		6.1
	262		6.5
	263		6.7
	264 265		7.1
K Patch	265		6.3 6.7
K PalCII	266 267		6.4
	268		2.6
	269		3.2
	270		3.2
	271		2.9
	272		2.5
	273		2.7
	273 274		3.3
	275		3
	276		2.9
	0	256	6.6
	1	257	6.3
	2	258	5.7
	3	258 259	5.6
	4	260	6
	5	261	3
	6	262	3.5
	7	263	3.4
	8	264	3.2
	9	265	3.3
	10	266	3.4
	11 12	267	3.2 -1.1
	13	268 269	-0.4
	13	269 270	-0.4
	15	270	-0.8
	16	272	-0.o -1.2
	17	273	-0.8
	18	274	-0.8
	19	275	-0.4
	20	276	-1
		L10	

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6. System Verification

The system was verified to be within ± 0.66 dB of the power density targets on the calibration certificate according to the test system specification in the user's manual and calibration facility recommendation. The 0.66 dB deviation threshold represents the expanded uncertainty for system performance checks using SPEAG's mmWave verification sources. The same spatial resolution and measurement region used in the source calibration was applied during the system check.

The measured power density distribution of verification source was also confirmed through visual inspection to have no noticeable differences, both spatially (shape) and numerically (level) from the distribution provide by the manufacturer, per November 2017 TCBC Workshop Notes.

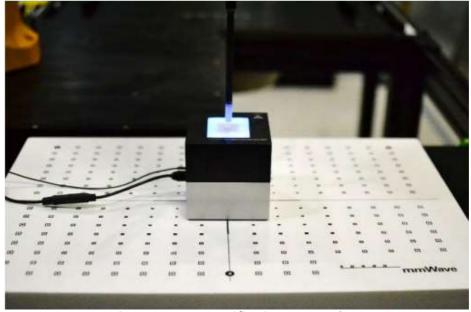


Fig. 6.1 System Verification Setup photo

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6.1 System Check Results

					Syste	m Verifica	ation				
	Freq.	Date	Ambient Temp.	Source	Probe	Normal psPD (W/m² over 4 m²)		Dev.		al psPD over 4 m²)	Dev.
	(GHz)		(°C)	S/N	S/N	Meas. target		(dB)	Meas.	target	(dB)
Part1	30	04/12/2024	19.0	1011	9486	16.0	14.6	+ 0.40	16.3	14.8	+ 0.42
Part1	30	04/15/2024	19.7	1011	9486	15.9	14.6	+ 0.37	16.2	14.8	+ 0.39
Part1	30	04/16/2024	19.4	1011	9486	15.8	14.6	+ 0.34	16.0	14.8	+ 0.34
Part1	30	04/17/2024	20.7	1011	9486	15.7	14.6	+ 0.32	16.0	14.8	+ 0.34
Part1	30	04/18/2024	20.2	1011	9486	14.7	14.6	+ 0.03	15.0	14.8	+ 0.06
Part1	30	04/19/2024	19.3	1011	9486	15.6	14.6	+ 0.29	15.9	14.8	+ 0.31
NSS	30	04/20/2024	20.5	1011	9486	15.7	14.6	+ 0.32	15.9	14.8	+ 0.31
NSS	30	04/22/2024	19.7	1011	9486	15.4	14.6	+ 0.23	15.6	14.8	+ 0.23
NSS	30	04/23/2024	19.9	1011	9486	15.4	14.6	+ 0.23	15.7	14.8	+ 0.26

Note: A 10mm Distance spacing was used from the reference horn antenna aperture to the probe element. This includes 4.45 mm from the reference antenna horn aperture to the surface of the verification source plus 5.55 mm from the surface to the probe. The SPEAG software requires a setting of "5.55 mm" for the correct setup

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7. Power Density Data Summary

7.1 Power Density Results

Power density measurements were performed with DUT transmitting at input.power.limit for one single beam for each polarization (H&V) and one beam pair, for each antenna on each worst surfaces

				n2	258 - Fold	er Open						
Frequ	ency	Ant.			Ant	Test	Distance	Power Drift	Normal psPD	Total psPD	Plot	
MHz	Ch.		V	Н	(dBm)		Position	(mm)	(dB)	(mW/cm²)	(mW/cm²)	No.
25 200	2032499		15	-	2.2	SISO	Rear	2	-0.04	0.156	0.302	-
25 200	2032499		20	-	1.8	SISO	Front	2	0.15	0.276	0.359	-
25 200	2032499		20	-	1.8	SISO	Left	2	-0.11	0.287	0.392	-
25 200	2032499		-	276	4.1	SISO	Rear	2	-0.12	0.277	0.356	-
25 200	2032499	K Patch	-	271	5.8	SISO	Front	2	-0.04	0.265	0.314	-
25 200	2032499		-	276	4.1	SISO	Left	2	-0.01	0.328	0.511	1
25 200	2032499		20	276	-1.0	MIMO	Rear	2	0.10	0.091	0.129	-
25 200	2032499		19	275	-0.3	MIMO	Front	2	0.03	0.170	0.228	-
25 200	2032499		20	276	-1.0	MIMO	Left	2	-0.07	0.200	0.294	-
		47 CFR		AFETY LIM	IT				wer Dei			
	Unce	ntrollad	Spatial Pe		oulation				1 mW/ci			
	Uncontrolled Exposure/ General Population							Avera	ged ove	r 4 Cm²		

				n2	58 - Folde	r Closed						
Freque	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot No.
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	NO.
25 200	2032499		15	-	2.2	SISO	Front	2	0.06	0.117	0.250	-
25 200	2032499		16	-	2.0	SISO	Left	2	0.13	0.319	0.465	4
25 200	2032499	K Patch	-	276	4.1	SISO	Front	2	-0.09	0.278	0.339	-
24 800.04	2025833	K PalCII	-	276	4.1	SISO	Left	2	-0.09	0.302	0.438	-
25 200	2032499		20	276	-1.0	MIMO	Front	2	-0.18	0.0804	0.109	-
25 200	2032499		20	276	-1.0	MIMO	Left	2	-0.11	0.291	0.384	-
		47 CFR	§1.1310 - S			Pc	wer Der	nsity				
			Spatial Pe				1 mW/cr	m²				
	Uncontrolled Exposure/ General Population							Avera	ged ove	r 4 cm²		

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	n261 - Folder Open												
Frequ	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot No.	
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	NO.	
27 550.08	2071667		15	-	1.4	SISO	Front	2	0.12	0.317	0.457	-	
27 550.08	2071667		15	-	1.4	SISO	Left	2	0.14	0.347	0.499	-	
27 550.08	2071667	K Patch	-	269	3.6	SISO	Front	2	0.13	0.181	0.228	-	
28 299.96	2084165	N PalCII	-	276	3.3	SISO	Left	2	0.12	0.290	0.575	2	
27 550.08	2071667		17	273	-1.1	MIMO	Front	2	-0.13	0.107	0.156	-	
27 550.08	2071667		17	273	-1.1	MIMO	Left	2	0.15	0.318	0.462	-	
	Unco		§1.1310 - S Spatial Pe Exposure/ (eak			•	wer Der I mW/cr ged ove	n² ์				

	n261 - Folder Closed													
Freque	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot		
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	No.		
27 550.08	2071667		15	-	1.4	SISO	Left	2	-0.12	0.354	0.514	-		
28 299.96	2084165	K Patch	-	272	3.1	SISO	Left	2	0.06	0.278	0.516	5		
28 299.96	2084165		16	272	-1.3	MIMO	Left	2	0.07	0.228	0.417	-		
		47 CFR	§1.1310 - S			Pc	wer Der	nsity						
			Spatial Pe			•	1 mW/cr	m²						
	Unco	ntrolled	Exposure/ (General Pop			Avera	ged ove	r 4 cm²					

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				n2	260 - Fold	er Open						
Freque	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot No.
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	NO.
37 050	2229999		20	-	2.4	SISO	Rear	2	-0.10	0.280	0.324	-
37 050	2229999		20	-	2.4	SISO	Left	2	-0.05	0.467	0.641	-
39 949.92	2278331		-	270	3.2	SISO	Rear	2	-0.11	0.199	0.335	-
37 050	2229999	K Patch	-	272	2.5	SISO	Left	2	-0.18	0.470	0.692	3
37 050	2229999		20	276	-1.0	MIMO	Rear	2	-0.01	0.269	0.343	-
37 050	2229999		16	272	-1.2	MIMO	Left	2	-0.03	0.435	0.622	-
37 050	2229999		-	272	2.5	SISO	Left	10	-0.14	0.369	0.431	-
	Unco			•	wer Der 1 mW/cr ged ove	m² ĺ						

	n260 - Folder Closed													
Freque	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot No.		
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	INO.		
38 499.96	2254165		20	-	2.4	SISO	Left	2	-0.13	0.444	0.606	-		
39 949.92	2278331	K Patch	-	271	2.9	SISO	Left	2	-0.02	0.442	0.621	-		
37 050	2229999	KPatCII	16	272	-1.2	MIMO	Left	2	0.02	0.402	0.622	6		
37 050	2229999		16	272	-1.2	MIMO	Left	5	0.12	0.389	0.563	-		
		47 CFR	§1.1310 - S			Pc	wer Der	nsity						
			Spatial Pe	eak			•	1 mW/cr	m²					
	Uncc	ntrolled	Exposure/ (General Pop			Avera	ged ove	r 4 cm²					

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7.2 Power Density Results -Non-Selected Surface validation

		n2	58 Non-	Selected	validatio	n- Fold	er Oper	ו				
Frequ	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot
MHz	Ch.		V	Η	(dBm)		Position	(mm)	(dB)	(mW/cm²)	(mW/cm²)	No.
24800.04	2025833	K Patch	-	268	9.6	SISO	Тор	2	-0.15	0.0323	0.0402	-
	47 CFR §1.1310 - SAFETY LIMIT Power Density											
			Spatial Pe			•	1 mW/c	m²				
	Unco	ntrolled I	Exposure/ G			Avera	ged ove	er 4 cm²				

	n258 Non-Selected Surface validation - Folder Close											
Freque	ency	Ant.	Beam ID1	ID1 Beam ID2 Input.power Ant	Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot		
MHz	Ch.		V	Н	(dBm)		Position	(mm)	(dB)	(mW/cm²)	(mW/cm²)	No.
24800.04	2025833	V Datch	15	-	2.2	SISO	Rear	2	-0.18	0.125	0.170	-
24800.04	2025833	K PalCII	-	273	7.3	SISO	Тор	2	-0.08	0.0620	0.0685	-
		47 CFR	§1.1310 - S	AFETY LIMI	IT		Power Density					
	Spatial Peak								1 mW/c	m²		
	Unco	ntrolled I	Exposure/ (General Pop	oulation			Avera	ged ove	er 4 cm²		

	n261 Non-Selected Surface validation - Folder Open												
Fre	Frequency		Ant.	Beam ID1	Beam ID2	Input.power		Test Position	Distance	Power Drift	Normal psPD	Total psPD	Plot No.
MHz		Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	NO.
27924.9		77915	K Patch	-	275	3.6	SISO	Rear	2	0.10	0.345	0.407	-
27924.9	6 20	77915	K PalCII	16	-	2.2	SISO	Тор	2	-0.10	0.0472	0.0505	-
	47 CFR §1.1310 - SAFETY LIMIT							Power Density					
	Spatial Peak								1 mW/cm ²				
		Unco	ntrolled I	Exposure/ (General Pop	oulation		Averaged over 4 cm ²					

		n26	1 Non-	Selected	Surface	validatio	n - Fold	der Clos	e				
Frequ	ency	Ant.	Beam ID1	Beam ID2	Input.power		Test Position	Distance	Power Drift	Normal psPD	psPD	Plot	
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	No.	
27924.96	2077915		17	-	2	SISO	Rear	2	-0.02	0.122	0.185	-	
27924.96	2077915	K Patch	-	274	3.7	SISO	Front	2	-0.02	0.314	0.335	-	
27924.96	2077915		12	-	2.2	SISO	Тор	2	0.19	0.0762	0.0773	-	
	47 CFR §1.1310 - SAFETY LIMIT								wer Dei	nsity			
	Spatial Peak								1 mW/cm ²				
	Unco	ntrolled E	xposure/ (General Pop	oulation			Avera	ged ove	er 4 cm²			

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	n260 Non-Selected Surface validation - Folder Open											
Frequ	ency	Ant.	Beam ID1	Beam ID2	Input.power	Ant	Test Position	Distance	Power Drift	Normal psPD	nsPD	Plot No.
MHz	Ch.		V	Н	(dBm)		POSITION	(mm)	(dB)	(mW/cm²)	(mW/cm²)	INO.
38499.96	2254165	K Patch	14	-	3.2	SISO	Front	2	0.13	0.411	0.423	-
38499.96	2254165	K PalCII	-	268	2.6	SISO	Тор	2	-0.17	0.0403	0.0410	-
	47 CFR §1.1310 - SAFETY LIMIT							Power Density				
	Spatial Peak								1 mW/c	m²		
	Unco	ntrolled I	Exposure/ (General Pop	oulation		Averaged over 4 cm ²					

		n26	0 Non-	Selected	Surface	validatio	n - Fold	der Clos	se			
Frequ	ency	Ant.	Beam ID1	Beam ID2	Input.power	Δητ	Test Position	Distance	Power Drift	Normal psPD	nsPD	Plot
MHz	Ch.		V	Н	(dBm)		Position	(mm)	(dB)	(mW/cm²)	(mW/cm²)	No.
38499.96	2254165		14	-	3.2	SISO	Rear	2	0.03	0.194	0.198	-
38499.96	2254165	K Patch	-	263	6.7	SISO	Front	2	-0.14	0.236	0.445	-
38499.96	2254165		12	-	3.5	SISO	Тор	2	-0.13	0.0419	0.0527	-
	47 CFR §1.1310 - SAFETY LIMIT								wer De	nsity		
	Spatial Peak								1 mW/c	m²		
	Unco	ntrolled E	xposure/ (General Pop	oulation			Avera	ged ove	er 4 cm ²		

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7.2 Power density Test Notes

General Notes:

- 1. The manufacturer has confirmed that the devices tested have the same physical, mechanical and thermal characteristics and are within operational tolerances expected for production units.
- 2. Batteries are fully charged at the beginning of the measurements. The DUT was connected to a wall charger for some measurements due to the test duration. It was confirmed that the charger plugged into this DUT did not impact the near-field PD test results.
- 3. Power density was calculated by repeated E-field measurements on two measurement planes separated by $\lambda/4$.
- 4. DUT was configured to transmit with a manufacturer provided test software to control specific antenna(s), Beam ID(s), and signal type to ensure the test configurations constant for the entire evaluation.
 - 5. Input.power.limit parameter for 5G mmW NR radio was calculated in Part 0 PD report.
- 6. Per FCC TCBC Workshop Notes Apr. 2020, when the device is using the Qualcommbased method already approved by FCC there is no need to submit a pre-submission (pre-TCB) KDB to have the test plan approved.
- 7. PD_design_target of 0.631 mW/cm² was used with mmW device design related uncertainty of 2 dB.
- 8. Input.power.limit parameter for 5G mmW NR radio was calculated in Part 0 Power Density Report.
- 9. This device is enabled with Qualcomm® Smart Transmit feature to control and manage transmitting power in real time and to ensure that the time-averaged RF exposure from WWAN and WLAN is in compliance with FCC requirements. Per FCC guidance for devices enabled with Qualcomm® Smart Transmit feature, 4G LTE/5G NR FR1, WLAN/BT, and 5G mmW NR FR2 simultaneous transmission scenario does not need to be evaluated under Total Exposure Ratio (TER). The validation of the time-averaging algorithm and compliance under the Tx varying transmission scenario for WWAN and WLAN technologies are reported in Part 2 report.
- 10. Per FCC guidance for devices enable with Qualcomm[®] Smart Transmit feature, simultaneous transmission analysis is evaluated by combining the exposure from External Radio NFC antenna. 5G mmW NR and NFC antenna. simultaneous transmission scenario is evaluated under the Total Exposure Ratio (TER) in Section 8.
- 11. The Beam ID with one of the highest initial simulated power density for that surface and distance was selected for Part 1 Power Density measurements.
- 12. The device was configured to transmit CW wave signal for testing. Per FCC guidance for devices enabled with Qualcomm® Smart Transmit feature, additional testing was not required for different modulations(CP-OFDM QPSK, CP-OFDM 16QAM, CP-OFDM 64QAM, DFT-s-ODFM Pi/2BPSK, DFT-s ODFM QPSK, DFT-s-OFDM 16QAM, DFT-s-ODFM 64QAM), RB configurations, component carriers, channel configurations(low channel, mid channel, high channel) since the smart transmit algorithm monitors powers on a per symbol basis, which is independent of these signal characteristics.
- 13. The device was configured to MIMO configuration with H and V polarization beams transmitting together..
- 14. In some cases, the simulation vs. measurement for some surfaces can exceed the device's total uncertainty. Therefore, some additional tests were performed to support simultaneous transmission analysis. See Section8.

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8. The Total Exposure Ratio

The Total Exposure Ratio (TER) is calculated by combining all SAR measurements and power density measurement after normalizing to their respective limits. The general expression is below.

$$TER = \sum_{a=1}^{A} \frac{SAR_a}{SAR_a, limit} + \sum_{b=1}^{B} \frac{psPD_b}{psPD_b, limit} < 1$$

The TER shall be less than unity to ensure compliance with the limits.

$$\sum_{n=1}^{N} \frac{4G \, SAR_n}{4G \, SAR_n, limit} + \sum_{m=1}^{M} \frac{5G \, mmW \, NR \, psPD_m}{5G \, mmW \, NR \, psPD_m, limit} + \sum_{p=1}^{P} \frac{WLAN \, SAR_p}{WLAN \, SAR_p, limit}$$

For 5G mmW NR, since there is total design-related uncertainty arising from TxAGC and device-to-device variation, the worst-case RF exposure should be determined by accounting for device uncertainty. For this device, the manufacturer has added an additional permanent back-off (indicated below as WWAN backoff) for every beam in the calculations for input.power.limits used in the EFS file. The back-off levels can be found in the Part 0 PD Test report. Therefore, 5G mmW NR RF exposure for this DUT is evaluated by reported psPD calculated as:

reported_psPD= (PD_design_target+PD_uncertainty) x 10(-WWAN backoff in dB)/10)

Note that since not all the beams supported by this EUT are measured, reported_psPD cannot be computed based on limited measured psPD data. Alternatively, since measured psPD for all the beams will be ≤PD_design_target + PD_uncertainty uncertainty, reported_psPD is computed based on this worst-case psPD as shown above.

Note that the above reported psPD applies to the worst-case surfaces of the DUT at 2mm evaluation distance. Worst-case PD on other surfaces of the DUT are calculated from simulated PD data (see Power Density Simulation Report), by multiplying reported psPD with the highest proportion out of all beams and out of all three channels in each band, where the adjustment for each beam/channel is computed as the proportion of "simulated PD on desired surface" to "simulated PD on worst-surface". For example, to determine worst-case PD on front surface (needed for Head RF Exposure evaluation during simultaneous transmission), highest proportion of (simulated PD on front surface)/(simulated PD on worst surface) was determined out of all supported beams and out of all three channels by the DUT in each band

In some cases, the simulation vs measurement for some surfaces can exceed the device's total uncertainty. In those cases, if the measured psPD > simulated adjusted psPD (assuming a linear congruency of the psPD across surfaces), then measured psPD should be used towards the simultaneous TX analysis. Table 8-1 lists the relevant worst-case reported psPD values based on the additional surfaces and evaluation distances needed to perform the TER analysis.

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The highest of the adjusted Reported_psPD and Measured Total psPD was chosen for TER analysis and the chosen values are indicated by bolded psPD values.

Table 8-1

			The worst-o	case reported p	osPD values – 2mm		
Antenna	Folder	Configuration	Evaluation	Adjustment Factor due to	Adjusted Reported psPD	Measured Total psPD	Final Reported psPD
Module	Open		Distance	Simulation	(mW/cm2)	(mW/cm2)	(mW/cm2)
		Rear	2 mm	0.693	0.677	0.356	0.677
		Front	2 mm	0.785	0.767	0.499	0.767
	Onan	Left	2 mm	1.000	0.977	0.692	0.977
	Open	Right	2 mm	0.043	0.042	=	0.042
		Тор	2 mm	0.092	0.090	0.0505	0.090
K		Bottom	2 mm	0.030	0.029	=	0.029
K		Rear	2 mm	0.407	0.398	0.198	0.398
		Front	2 mm	0.710	0.694	0.339	0.694
	Cl	Left	2 mm	1.000	0.977	0.622	0.977
	Close	Right	2 mm	0.061	0.060	-	0.060
		Тор	2 mm	0.261	0.255	0.0773	0.255
		Bottom	2 mm	0.108	0.106	-	0.106

Note: Adjusted f actor is (simulated PD on desired exposure plane)/(PD o n worst-surf ace at 2mm evaluation distance) out of all beams and out of all channels. See Power Density Simulation Report

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8.1 Total Exposure Ratio for each exposure condition

Table 8-2
5G mmWave NR Phablet Total Exposure Ratio

	NR FR2	Worst case NFC Reported SAR	NR FR2+NFC
	W/cm ²	W/kg	
Applicable Limit	1	4.0	1.0
Reported Value	0.977	0.00743	
Ratio to limit	0.977	0.002	0.979

Note:

- 1. Worst case Power density results for each test configuration among all antenna arrays and among all supported bands were considered for TER Analysis.
- 2. For Power density measurements, a test separation distance of 2mm was used for phablet configuration due to mmWave probe restraints.
- 3. The worst-case between Adjusted Reported_psPD and Measured Total psPD was chosen for TER analysis.
- 4. The worst-case between Adjusted_Reported_psPD and measured Total psPD was chosen for TER analysis.

The above numerical summed PD and SAR for all the worst case simultaneous transmission conditions were Total Exposure Ratio.

Therefore, the above analysis is sufficient to determine no further test cases are required and that simultaneous transmission is compliant to the FCC RF exposure limit.

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9. Measurement Uncertainty

а	b	С	d	е	f = b x e / d	g
Source of uncertainty	Uncertainty Value	Probability	Div.	ci	Standard Uncertainty	Vi
·	(± dB)	distribution			(± dB)	
Probe calibration	0.49	N	1	1	0.49	00
Probe correction	0.00	R	1.73	1	0.00	00
Frequency Response(BW≤ 1GHz)	0.20	R	1.73	1	0.12	∞
Sensor cross coupling	0.00	R	1.73	1	0.00	00
stropy	0.50	R	1.73	1	0.29	00
Linearity	0.20	R	1.73	1	0.12	∞
Probe scattering	0.00	R	1.73	1	0.00	∞
Probe positioning offset	0.30	R	1.73	1	0.17	∞
Probe positioning Repeatability	0.04	R	1.73	1	0.02	∞
Probe spatial Resolution	0.00	R	1.73	1	0.00	00
Field Impedence Dependence	0.00	R	1.73	1	0.00	∞
Sensor Mechanical Offset	0.00	R	1.73	1	0.00	00
Amplitude and Phase noise	0.04	R	1.73	1	0.02	∞
Measurement area truncation	0.00	R	1.73	1	0.00	∞
Data acquisition	0.03	N	1	1	0.03	∞
Field Reconstruction	0.60	R	1.73	1	0.35	∞
Forward Transformation	0.00	R	1.73	1	0.00	
Power density Scailing	0.00	R	1.73	1	0.00	∞
Spatial Averaging	0.10	R	1.73	1	0.06	
Test sample and Environmental Factors			1.70	ļ '	0.00	
Probe coupling with DUT	0.00	R	1.73	1	0.00	00
Modulation Response	0.40	R	1.73	1	0.23	∞
Integration time	0.00	R	1.73	1	0.00	00
Response time	0.00	R	1.73	1	0.00	∞
Device holder influence	0.10	R	1.73	1	0.06	∞
DUT alignment	0.00	R	1.73	1	0.00	∞
RF Ambient Conditions	0.04	R	1.73	1	0.02	∞
RF ambient - reflections	0.04	R	1.73	1	0.02	∞
mmunity/Secondary Reception	0.00	R	1.73	1	0.00	∞
Power Drif of DUT	0.21	R	1.73	1	0.12	∞
Combined standard uncertainty (k = 1)		RSS	-		0.76	∞
Expanded uncertainty (95% confidence level)		k = 2			1.52	

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10 Power Density Test Equipment

Manufacturer	Type / Model	S/N	Calib. Date	Calib.Interval	Calib.Due
SPEAG	5G Module Phantom	-	N/A	N/A	N/A
HP	SAR System Control PC	ı	N/A	N/A	N/A
Staubli	CS8Cspeag-TX90	F17/ 59CHA1/ C/ 01	N/A	N/A	N/A
Staubli	TX90 XLspeag	F17/ 59RAA1/ A/ 01	N/A	N/A	N/A
Staubli	Teach Pendant (Joystick)	010963	N/A	N/A	N/A
SPEAG	DAE4	1687	07/18/2023	Annual	07/18/2024
SPEAG	E-Field Probe EUmmWV4	9486	06/19/2023	Annual	06/19/2024
SPEAG	Dipole 5G Verification Source 30 GHz	1011	07/13/2023	Annual	07/13/2024
TESTO	175-H1/Thermometer	40331915309	12/26/2023	Annual	12/26/2024

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11. Conclusion

The Power density measurements and total exposure ratio analysis indicate that the DUT complies with the RF radiation exposure limits of the FCC, with respect to all parameters subject to this test. These measurements were taken to simulate the RF effects of RF exposure under worst-case conditions. Precise laboratory measures were taken to assure repeatability of the tests. The results and statements relate only to the item(s) tested.

Please note that the RF Exposure and distribution of electromagnetic energy in the body are very complex phenomena that depend on the mass, shape, and size of the body, the orientation of the body with respect to the field vectors, and the electrical properties of both the body and the environment. Other variables that may play a substantial role in possible biological effects are those that characterize the environment (e.g. ambient temperature, air velocity, relative humidity, and body insulation) and those that characterize the individual (e.g. age, gender, activity level, debilitation, or disease). Because various factors may interact with one another to vary the specific biological outcome of an exposure to electromagnetic fields, any protection guide should consider maximal amplification of biological effects as a result of field-body interactions, environmental conditions, and physiological variables.

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12. References

- [1] ANSI/IEEE C95.1-1992, American National Standard safety levels with respect to human exposure to radio frequency electromagnetic fields, 3kHz to 300Ghz, New York: IEEE, Sep. 1992.
- [2] IEC TR 63170:2018, Measurement Procedure for the Evaluation of Power Density Related to Human Exposure to Radiofrequency Fields from Wireless Communication Devices Operating between 6GHz and 100GHz.
- [3] IEC TR 62630:2010, Guidance for Evaluating Exposure from Multiple Electromagnetic Sources.
- [4] K. Pokovic, T. Schmid, J. Frohlich, and N. Kuster. Novel Probes and Evaluation Procedures to Assess Field Magnitude and Polarization. IEEE Transactions on Electromagnetic Compatibility 42(2): 240 244, 2000.
- [5] R. W. Gerchberg and W. O. Saxton. A Practical Algorithm for the Determination of Phase from Image and Diffraction Plane Pictures. Optik 35(2): 237 346, 1972.
- [6] A. P. Anderson and S. Sali. New Possibilities for Phaseless Microwave Diagnostics. Part 1: Error Reduction Techniques. IEE Proceedings H Microwaves, Antennas and Propagation 132(5): 290 298, 1985.
- [7] FCC KDB 865664 D02 v01r04: SAR Measurement Requirements for 100 MHz to 6GHz. Federal Communications Commission Office of Engineering and Technology, Laboratory Division.
- [8] FCC KDB 447498 D01 v06: RF Exposure Procedures and Equipment Authorization Policies for Mobile and Portable Devices. Federal Communications Commission Office of Engineering and Technology, Laboratory Division.
- [9] November 2017 Telecommunications Certification Body Council (TCBC) Workshop Notes
- [10] October 2018 Telecommunications Certification Body Council (TCBC) Workshop Notes
- [11] April 2019 Telecommunications Certification Body Council (TCBC) Workshop Notes
- [12] November 2019 Telecommunications Certification Body (TCBC) Workshop Notes
- [13] SPEAG DASY6 System Handbook (September 2019)

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Appendix A. – DUT Ant. Information & SETUP PHOTO

Please refer to test DUT Ant. Information & setup photo file no. as follows:

Report No.
HCT-SR-2404-FC005-P

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Appendix B. – Power Density Test Plots

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Test Laboratory: HCT CO., LTD EUT Type: Mobile Phone Ambient Temperature: 19.0 °C Test Date: 04/12/2024 Plot No.:

Measurement Report for Device, EDGE LEFT, Custom Band, CW, Channel 25200000 (25200.0 MHz)

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G	EDGE LEFT, 2.00	NR n258	CW, 0	25200.0, 25200000	1.0

Hardware Setup

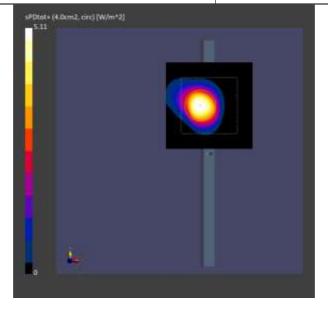
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.17158298424721127 x 0.17158298424721127
Sensor Surface [mm]	2.0

Measurement Results

Wedsarement Results	
Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	3.28
psPDtot+ [W/m²]	5.11
E _{max} [V/m]	91.2
Power Drift [dB]	-0.01



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Test Laboratory: HCT CO., LTD EUT Type: Mobile Phone Ambient Temperature: 19.4 °C Test Date: 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD Mobile Phone 19.4 °C 04/16/2024 Plot No.: 4CT CO., LTD CO.,

Measurement Report for Device, EDGE LEFT, Custom Band, CW, Channel 28300000 (28300.0 MHz)

Exposure Conditions

Exposure com	aitions				
Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G	EDGE LEFT, 2.00	NR n261	CW, 0	28300.0, 28300000	1.0

Hardware Setup

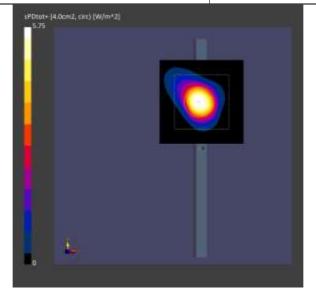
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date	
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18	

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.19269041484905072 x 0.19269041484905072
Sensor Surface [mm]	2.0

Measurement Results

Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	2.90
psPDtot+ [W/m²]	5.75
E _{max} [V/m]	102
Power Drift [dB]	0.12



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Test Laboratory: HCT CO., LTD EUT Type: Mobile Phone Ambient Temperature: 19.7 °C Test Date: 04/15/2024 Plot No.: 3

Measurement Report for Device, EDGE LEFT, Custom Band, CW, Channel 37050000 (37050.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	EDGE LEFT, 2.00	NR n260	CW, 0	37050.0, 37050000	1.0

Hardware Setup

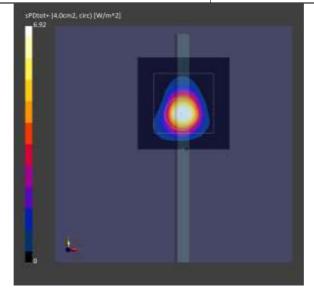
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	2.0

Measurement Results

Scan Type	5G Scan
Avg. Area [cm ²]	4.00
psPDn+ [W/m²]	4.70
psPDtot+ [W/m²]	6.92
E _{max} [V/m]	131
Power Drift [dB]	-0.18



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Test Laboratory: HCT CO., LTD EUT Type: Mobile Phone Ambient Temperature: 20.7 °C Test Date: 04/17/2024 Plot No.:

Measurement Report for Device, EDGE LEFT, Custom Band, CW, Channel 25200000 (25200.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	EDGE LEFT, 2.00	NR n258	CW, 0	25200.0, 25200000	1.0

Hardware Setup

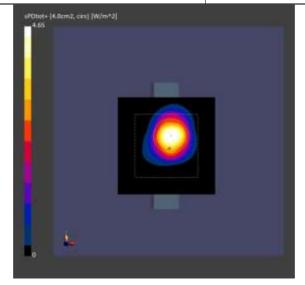
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.17158298424721127 x 0.17158298424721127
Sensor Surface [mm]	2.0

Measurement Results

Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	3.19
psPDtot+ [W/m²]	4.65
E _{max} [V/m]	92.3
Power Drift [dB]	0.13



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Test Laboratory: HCT CO., LTD EUT Type: Mobile Phone Ambient Temperature: 19.3 °C Test Date: 04/19/2024 Plot No.: 5

Measurement Report for Device, EDGE LEFT, Custom Band, CW, Channel 28300000 (28300.0 MHz)

Exposure Conditions

Exposure con	ai di Giio				
Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G	EDGE LEFT, 2.00	NR n261	CW, 0	28300.0, 28300000	1.0

Hardware Setup

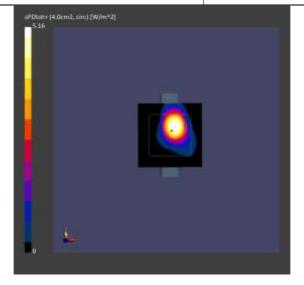
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.19269041484905072 x 0.19269041484905072
Sensor Surface [mm]	2.0

Measurement Results

Medada ement Redaile	
Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	2.78
psPDtot+ [W/m²]	5.16
E _{max} [V/m]	108
Power Drift [dB]	0.06



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Test Laboratory: HCT CO., LTD EUT Type: Mobile Phone Ambient Temperature: 20.2 °C Test Date: 04/18/2024 Plot No.: 6

Measurement Report for Device, EDGE LEFT, Custom Band, CW, Channel 37050000 (37050.0 MHz)

Exposure Conditions

Exposure Cont	artions				
Phantom Section	Position, Test Distance [mm]	Band		Frequency [MHz], Channel Number	Conversion Factor
5G	EDGE LEFT, 2.00	NR n260	CW, 0	37050.0, 37050000	1.0

Hardware Setup

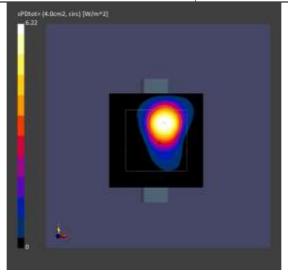
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Jeans Jetup	
Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	2.0

Measurement Results

Wicasar Cilicit Results	
Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	4.02
psPDtot+ [W/m²]	6.22
E _{max} [V/m]	102
Power Drift [dB]	0.02



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Appendix C. – System Check Plots

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Test Laboratory: HCT CO., LTD Ambient Temp.: 19.0 ℃ Test Date: 04/12/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

Hardware Setup

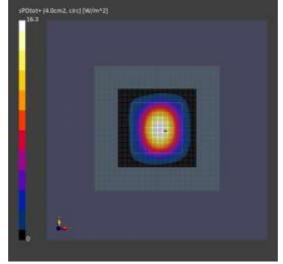
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results
Scan Type

Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	16.0
psPDtot+ [W/m²]	16.3
E _{max} [V/m]	93.9
Power Drift [dB]	0.06



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5G Scan 4.00



■ Verification Data (30 础)

Test Laboratory: HCT CO., LTD Ambient Temp.: 19.7 $^{\circ}$ C Test Date: 04/15/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date	
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18	

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results		
Scan Type		
Avg. Area [cm²]		
nsPDn+ [W/m²]		

psPDn+ [W/m²]	15.9
psPDtot+ [W/m²]	16.2
E _{max} [V/m]	93.9
Power Drift [dB]	0.12

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Test Laboratory: HCT CO., LTD Ambient Temp.: 19.4 $^{\circ}$ C Test Date: 04/16/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

Hardware Setup

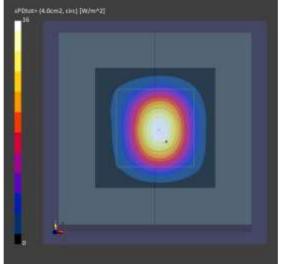
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement	Results
СТ	

Scan Type	5G Scan
Avg. Area [cm ²]	4.00
psPDn+ [W/m²]	15.8
psPDtot+ [W/m²]	16.0
E _{max} [V/m]	93.4
Power Drift [dB]	0.03



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Test Laboratory: HCT CO., LTD Ambient Temp.: $20.7 \,^{\circ}\text{C}$ Test Date: 04/17/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

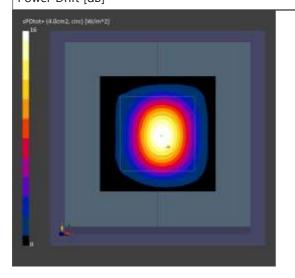
Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date	
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18	

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results	
Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	15.7
psPDtot+ [W/m²]	16.0
E _{max} [V/m]	93.5
Power Drift [dB]	0.08



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Test Laboratory: HCT CO., LTD Ambient Temp.: $20.2 \,^{\circ}\text{C}$ Test Date: 04/18/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0	

Hardware Setup

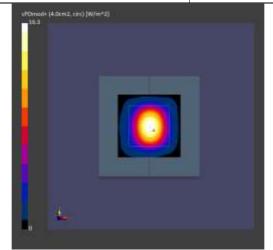
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results

Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	14.7
psPDtot+ [W/m²]	15.0
E _{max} [V/m]	94.0
Power Drift [dB]	0.02



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Test Laboratory: HCT CO., LTD Ambient Temp.: 19.3 $^{\circ}$ C Test Date: 04/19/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

Hardware Setup

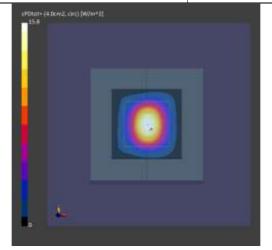
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Seans Setup	
Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results

Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	15.6
psPDtot+ [W/m²]	15.9
E _{max} [V/m]	94.3
Power Drift [dB]	0.06



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Test Laboratory: HCT CO., LTD Ambient Temp.: 20.5 ℃ Test Date: 04/20/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

Hardware Setup

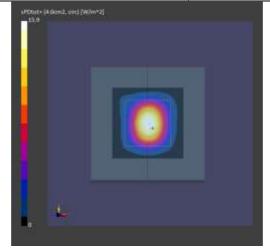
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

<u>Measurement</u>	Results
Scan Type	

Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	15.7
psPDtot+ [W/m²]	15.9
E _{max} [V/m]	94.2
Power Drift [dB]	0.00



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Test Laboratory: HCT CO., LTD Ambient Temp.: 19.7 $^{\circ}$ C Test Date: 04/22/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

Hardware Setup

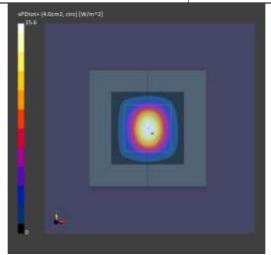
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Ν	⁄leas	urem	ent	Resu	<u>ılts</u>

weasurement results	
Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	15.4
psPDtot+ [W/m²]	15.6
E _{max} [V/m]	93.6
Power Drift [dB]	0.02



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Test Laboratory: HCT CO., LTD Ambient Temp.: 19.9 $^{\circ}$ C Test Date: 04/23/2024

Measurement Report for Device, FRONT, Validation band, CW, Channel 30000 (30000.0 MHz)

Exposure Conditions

Phantom	Position, Test	Band	Group,	Frequency [MHz],	Conversion
Section	Distance [mm]		UID	Channel Number	Factor
5G	FRONT, 5.55	Validation band	CW, 0	30000.0, 30000	1.0

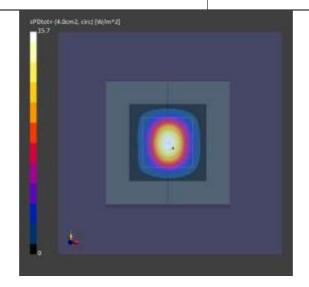
Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave	Air -	EUmmWV4 - SN9486_F1-55GHz, 2023-06-19	DAE4 Sn1687, 2023-07-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results	
Scan Type	5G Scan
Avg. Area [cm²]	4.00
psPDn+ [W/m²]	15.4
psPDtot+ [W/m²]	15.7
E _{max} [V/m]	93.6
Power Drift [dB]	0.04



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